## OptiMOS ${ }^{\text {TM }}$-T Power-Transistor

Product Summary

| $V_{\mathrm{DS}}$ | 120 | V |
| :--- | :---: | :--- |
| $R_{\mathrm{DS} \text { (on), max }}$ | 31 | $\mathrm{~m} \Omega$ |
| $I_{\mathrm{D}}$ | 30 | A |

## Features

- OptiMOS ${ }^{\text {TM }}$ - power MOSFET for automotive applications
- N -channel - Enhancement mode
- Automotive AEC Q101 qualified
- MSL1 up to $260^{\circ} \mathrm{C}$ peak reflow
- $175^{\circ} \mathrm{C}$ operating temperature

PG-TO252-3-11


- RoHS compliant
- 100\% Avalanche tested

| Type | Package | Marking |
| :--- | :--- | :--- |
| IPD30N12S3L-31 | PG-TO252-3-11 | 3N12L31 |



Maximum ratings, at $T_{\mathrm{j}}=25^{\circ} \mathrm{C}$, unless otherwise specified

| Parameter | Symbol | Conditions | Value | Unit |
| :--- | :--- | :--- | :---: | :--- |
| Continuous drain current | $I_{\mathrm{D}}$ | $T_{\mathrm{C}}=25^{\circ} \mathrm{C}, V_{\mathrm{GS}}=10 \mathrm{~V}$ | 30 | A |
|  |  | $T_{\mathrm{C}}=100^{\circ} \mathrm{C}, V_{\mathrm{GS}}=10 \mathrm{~V}^{1)}$ | 20 |  |
| Pulsed drain current ${ }^{1)}$ |  | $I_{\mathrm{D}, \text { pulse }}$ | $T_{\mathrm{C}}=25^{\circ} \mathrm{C}$ | 120 |
| Avalanche energy, single pulse ${ }^{1)}$ | $E_{\mathrm{AS}}$ | $I_{\mathrm{D}}=15 \mathrm{~A}$ | 138 | mJ |
| Avalanche current, single pulse | $I_{\text {AS }}$ | - | 30 | A |
| Gate source voltage ${ }^{3)}$ | $V_{\mathrm{GS}}$ | - | $\pm 20$ | V |
| Power dissipation | $P_{\text {tot }}$ | $T_{\mathrm{C}}=25^{\circ} \mathrm{C}$ | 57 | W |
| Operating and storage temperature | $T_{\mathrm{j}}, T_{\text {stg }}$ | - | $-55 \ldots+175$ | ${ }^{\circ} \mathrm{C}$ |


| Parameter | Symbol | Conditions |  |  | Values |  |  | Unit |
| :--- | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  |  | min. | typ. | max. |  |  |  |

## Thermal characteristics ${ }^{1)}$

| Thermal resistance, junction - case | $R_{\text {thJc }}$ | - | - | - | 2.6 |
| :--- | :--- | :--- | :---: | :---: | :---: |
| SMD version, device on PCB | $R_{\text {thJA }}$ | minimal footprint | - | - | 62 |
|  |  |  | $6 \mathrm{~cm}^{2}$ cooling area $\left.^{2}\right)$ | - | - |

Electrical characteristics, at $T_{\mathrm{j}}=25^{\circ} \mathrm{C}$, unless otherwise specified

## Static characteristics

| Drain-source breakdown voltage | $V_{(\mathrm{Br}) \mathrm{DSS}}$ | $V_{G S}=0 \mathrm{~V}, I_{\mathrm{D}}=1 \mathrm{~mA}$ | 120 | - | - | V |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| Gate threshold voltage | $V_{\text {GS(th) }}$ | $V_{\text {DS }}=V_{\text {GS }}, I_{\text {D }}=29 \mu \mathrm{~A}$ | 1.2 | 1.7 | 2.4 |  |
| Zero gate voltage drain current | $I_{\text {Dss }}$ | $\begin{aligned} & V_{\mathrm{DS}}=120 \mathrm{~V}, V_{\mathrm{GS}}=0 \mathrm{~V}, \\ & T_{\mathrm{j}}=25^{\circ} \mathrm{C} \end{aligned}$ | - | 0.01 | 0.1 | $\mu \mathrm{A}$ |
|  |  | $\begin{aligned} & V_{\mathrm{DS}}=120 \mathrm{~V}, V_{\mathrm{GS}}=0 \mathrm{~V}, \\ & T_{\mathrm{j}}=125^{\circ} \mathrm{C}^{1)} \end{aligned}$ | - | 1 | 10 |  |
| Gate-source leakage current | $I_{\text {GSS }}$ | $V_{\text {GS }}=20 \mathrm{~V}, V_{\text {DS }}=0 \mathrm{~V}$ | - | - | 100 | nA |
| Drain-source on-state resistance | $R_{\text {DS(on) }}$ | $V_{G S}=4.5 \mathrm{~V}, I_{\text {D }}=30 \mathrm{~A}$ | - | 32 | 42 | $\mathrm{m} \Omega$ |
|  |  | $V_{G S}=10 \mathrm{~V}, I_{\mathrm{D}}=30 \mathrm{~A}$ | - | 26 | 31 |  |


| Parameter | Symbol | Conditions | Values |  |  | Unit |
| :--- | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  |  | min. | typ. | max. |  |

## Dynamic characteristics ${ }^{1)}$

| Input capacitance | $C_{\text {iss }}$ | $\begin{aligned} & V_{\mathrm{GS}}=0 \mathrm{~V}, V_{\mathrm{DS}}=25 \mathrm{~V}, \\ & f=1 \mathrm{MHz} \end{aligned}$ | - | 1520 | 1976 | pF |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| Output capacitance | $C_{\text {oss }}$ |  | - | 380 | 494 |  |
| Reverse transfer capacitance | $\mathrm{C}_{\text {rss }}$ |  | - | 45 | 68 |  |
| Turn-on delay time | $t_{\text {d(on) }}$ | $\begin{aligned} & V_{\mathrm{DD}}=20 \mathrm{~V}, V_{\mathrm{GS}}=10 \mathrm{~V}, \\ & I_{\mathrm{D}}=30 \mathrm{~A}, R_{\mathrm{G}}=3.5 \Omega \end{aligned}$ | - | 6 | - | ns |
| Rise time | $t_{r}$ |  | - | 4 | - |  |
| Turn-off delay time | $t_{\text {d(off) }}$ |  | - | 18 | - |  |
| Fall time | $t_{\text {f }}$ |  | - | 3 | - |  |

## Gate Charge Characteristics ${ }^{1)}$

| Gate to source charge | $Q_{\text {gs }}$ | $\begin{aligned} & V_{\mathrm{DD}}=96 \mathrm{~V}, I_{\mathrm{D}}=30 \mathrm{~A}, \\ & V_{\mathrm{GS}}=0 \text { to } 10 \mathrm{~V} \end{aligned}$ | - | 5 | 7 | nc |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| Gate to drain charge | $Q_{\mathrm{gd}}$ |  | - | 4 | 6 |  |
| Gate charge total | $Q_{g}$ |  | - | 24 | 31 |  |
| Gate plateau voltage | $V_{\text {plateau }}$ |  | - | 3.7 | - | V |

## Reverse Diode

| Diode continous forward current ${ }^{11}$ | 1 s | $T_{\mathrm{C}}=25^{\circ} \mathrm{C}$ | - | - | 30 | A |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| Diode pulse current ${ }^{1)}$ | $I_{\text {s,pulse }}$ |  | - | - | 120 |  |
| Diode forward voltage | $V_{\text {SD }}$ | $\begin{aligned} & V_{\mathrm{GS}}=0 \mathrm{~V}, I_{\mathrm{F}}=30 \mathrm{~A}, \\ & T_{\mathrm{j}}=25^{\circ} \mathrm{C} \end{aligned}$ | 0.6 | 1 | 1.2 | V |
| Reverse recovery time ${ }^{1)}$ | $t_{\text {rr }}$ | $\begin{aligned} & V_{\mathrm{R}}=60 \mathrm{~V}, I_{\mathrm{F}}=I_{\mathrm{S}}, \\ & \mathrm{~d} i_{\mathrm{F}} / \mathrm{d} t=100 \mathrm{~A} / \mu \mathrm{s} \end{aligned}$ | - | 72 | - | ns |
| Reverse recovery charge ${ }^{1)}$ | $Q_{\text {Ir }}$ |  | - | 150 | - | nC |

${ }^{1)}$ Defined by design. Not subject to production test.
${ }^{\text {2) }}$ Device on $40 \mathrm{~mm} \times 40 \mathrm{~mm} \times 1.5 \mathrm{~mm}$ epoxy PCB FR4 with 6 cm 2 (one layer, $70 \mu \mathrm{~m}$ thick) copper area for drain connection. PCB is vertical in still air.
${ }^{3)}-5 \mathrm{~V}$ to -20V for max. 168 non-consecutive hours

1 Power dissipation
$P_{\text {tot }}=\mathrm{f}\left(T_{\mathrm{C}}\right) ; V_{\mathrm{GS}}=10 \mathrm{~V}$


3 Safe operating area
$I_{\mathrm{D}}=\mathrm{f}\left(V_{\mathrm{DS}}\right) ; T_{\mathrm{C}}=25^{\circ} \mathrm{C} ; D=0$
parameter: $t_{\mathrm{p}}$


## 2 Drain current

$I_{\mathrm{D}}=\mathrm{f}\left(T_{\mathrm{C}}\right) ; V_{\mathrm{GS}}=10 \mathrm{~V}$


4 Max. transient thermal impedance
$Z_{\text {thJC }}=\mathrm{f}\left(t_{\mathrm{p}}\right)$
parameter: $D=t_{\mathrm{p}} / T$


5 Typ. output characteristics
$I_{\mathrm{D}}=\mathrm{f}\left(V_{\mathrm{DS}}\right) ; T_{\mathrm{j}}=25^{\circ} \mathrm{C}$
parameter: $V_{\text {GS }}$


7 Typ. transfer characteristics
$I_{\mathrm{D}}=\mathrm{f}\left(V_{\mathrm{GS}}\right) ; V_{\mathrm{DS}}=6 \mathrm{~V}$
parameter: $T_{\mathrm{j}}$


6 Typ. drain-source on-state resistance
$R_{\text {DS(on) }}=\mathrm{f}\left(I_{\mathrm{D}}\right) ; T_{\mathrm{j}}=25^{\circ} \mathrm{C}$
parameter: $V_{\text {GS }}$


8 Typ. drain-source on-state resistance
$R_{\mathrm{DS}(\text { on })}=\mathrm{f}\left(T_{\mathrm{j}}\right) ; I_{\mathrm{D}}=30 \mathrm{~A} ; V_{\mathrm{GS}}=10 \mathrm{~V}$
$\alpha=0.4$


9 Typ. gate threshold voltage
$V_{\mathrm{GS}(\mathrm{th})}=\mathrm{f}\left(T_{\mathrm{j}}\right) ; V_{\mathrm{GS}}=V_{\mathrm{DS}}$
parameter: $I_{\mathrm{D}}$

10 Typ. capacitances
$C=\mathrm{f}\left(\mathrm{V}_{\mathrm{DS}}\right) ; V_{\mathrm{GS}}=0 \mathrm{~V} ; f=1 \mathrm{MHz}$

11 Typical forward diode characteristics
$I_{F}=f\left(V_{S D}\right)$
parameter: $T_{\mathrm{j}}$


12 Typ. avalanche characteristics
$I_{\mathrm{AS}}=\mathrm{f}\left(t_{\mathrm{AV}}\right)$
parameter: $T_{\mathrm{j} \text { (start) }}$


13 Typical avalanche energy
$E_{\text {AS }}=f\left(T_{\mathrm{j}}\right)$
parameter: $I_{D}$


15 Typ. gate charge
$V_{G S}=f\left(Q_{\text {gate }}\right) ; I_{D}=30$ A pulsed
parameter: $V_{D D}$


14 Typ. drain-source breakdown voltage
$V_{(\text {Br } D \text { Ds }}=f\left(T_{\mathrm{j}}\right) ; I_{\mathrm{D}}=1 \mathrm{~mA}$


16 Gate charge waveforms


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## Document reference

## IPD30N12S3L-31-Data-Sheet-

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Revision History

| Version | Date | Changes |
| :--- | :--- | :--- |
| Revision 1.0 | $2016-06-20$ | Final Data Sheet |
| Revision 1.1 | $2023-06-15$ | Diagram 8 Typ. drain-source on- <br> state resistance: used $\alpha$ value <br> clarified |
| Revision 1.1 | Ratings of $V_{\text {Gs }}$ refined <br> in footnote ${ }^{3)}$ |  |
| Revision 1.1 | $2023-06-15$ | Corrected diagram 10 typical <br> capacitances |

